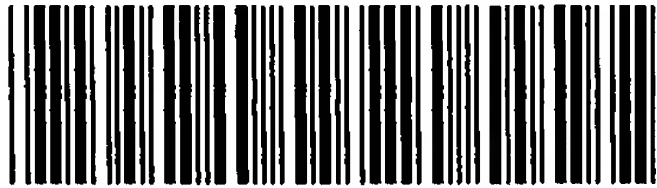


**Search Notes**

Application/Control No.

10/647,540

Examiner

Alex Liew

Applicant(s)/Patent under  
Reexamination

NAPHADE ET AL.

Art Unit

2624

**SEARCHED**

Class	Subclass	Date	Examiner
382	227	1/17/2007	AL
382	180	1/19/2007	AL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
382/224 limited to text search	1/17/2007	AL
382/181 limited to text search	1/28/2007	AL
382/173 limited to text search	1/19/2007	AL
382/117 limited to text search	1/25/2007	AL
382/115,117,118,181,,190,224,227 Limited to text search	5/21/2007	AL